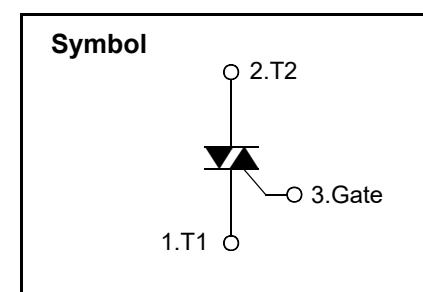
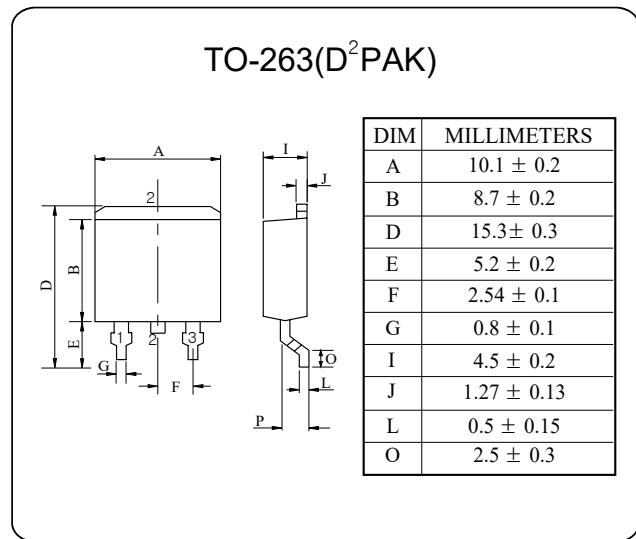


## Bi-Directional Triode Thyristor

Designed for high performance full-wave ac control applications where high noise immunity and high commutating di/dt are required.

### Features

- Blocking Voltage to 800V
- On-State Current Rating of 12A RMS at 110°C
- Uniform Gate Trigger Currents in Three Quadrants
- High Immunity to dV/dt-1500V/us minimum at 125°C
- Minimizes Snubber Networks for Protection
- Industry Standard TO-263 Package
- High Commutating di/dt- 4.0A/ms minimum at 125°C
- Internally Isolated (2500VRMS)
- These are Pb-Free Devices



### Absolute Maximum Ratings

Symbol	Parameter			Value	Unit
$I_{T(RMS)}$	RMS on-state current(full sine wave)	TO-263	$T_C=110^\circ C$	12	A
$I_{TSM}$	Non repetitive surge peak on-state current(full cycle, $T_j$ initial=25°C)	$F=50Hz$	$t=20ms$	120	A
		$F=60Hz$	$t=16.7ms$	126	
$I^2t$	$I^2t$ Value for fusing	$t_p=10ms$		78	$A^2s$
DI/DT	Critical rate of rise of on-state current $IG=2X_{IGT,tr\leq 100ns}$	$F=120Hz$	$T_j=125^\circ C$	50	$A/us$
VDSM/V RSM	Non repetitive surge peak off-state voltage	$t_p=10ms$	$T_j=25^\circ C$	$V_{drm} / v_{rrm} + 100V$	
IGM	Peak gate current	$t_p=20us$	$T_j=125^\circ C$	4	A
$P_{G(AV)}$	Average gate power dissipation	$T_j=125^\circ C$		1	W
$T_{stg}$	Storage junction temperature range			-40 to +150	$^\circ C$
$T_j$	Operating junction temperature range			-40 to +125	



# BT12DD-600B

## Electrical Characteristics (T<sub>j</sub>=25°C, unless otherwise specified)

### Snubberless™ and Logic Level(3 quadrants)

Symbol	Test conditions	Quadrant	BT12DD-600B		Unit
I <sub>GT</sub> (1)	V <sub>D</sub> =12V R <sub>L</sub> =33Ω	I - II - III	MAX	50	mA
V <sub>GT</sub>		I - II - III	MAX	1.3	V
V <sub>GD</sub>	V <sub>D</sub> =V <sub>DRM</sub> R <sub>L</sub> =3.3KΩ T <sub>j</sub> =125°C	I - II - III	MIN	0.2	V
I <sub>H</sub> (2)	I <sub>T</sub> =100mA I <sub>G</sub> =1.2I <sub>GT</sub>	I - III II	MAX	50	mA
I <sub>L</sub>			MAX	70	mA
				80	
D <sub>v</sub> / D <sub>t</sub> (2)	V <sub>D</sub> =67%V <sub>DRM</sub> Gate open T <sub>j</sub> =125°C		MIN	1000	V/us
(D <sub>l</sub> /d <sub>t</sub> )c(2)	(D <sub>v</sub> /d <sub>t</sub> )c=0.1 V/us T <sub>j</sub> =125°C	MIN	-	A/ms	
	(D <sub>v</sub> /d <sub>t</sub> )c=10V/us T <sub>j</sub> =125°C		-		
	Without snubber T <sub>j</sub> =125°C		12		

### Standard (4 Quadrants)

Symbol	Test conditions	Quadrant	BT12DD-600B		Unit
I <sub>GT</sub> (1)	V <sub>D</sub> =12V R <sub>L</sub> =33Ω	I - II - III	MAX	50	mA
V <sub>GT</sub>		IV		100	
V <sub>GD</sub>	V <sub>D</sub> =V <sub>DRM</sub> R <sub>L</sub> =3.3KΩ T <sub>j</sub> =125°C	ALL	MAX	1.3	V
I <sub>H</sub> (2)	I <sub>T</sub> =500mA		MAX	50	mA
I <sub>L</sub>	I <sub>G</sub> =1.2I <sub>GT</sub>	I - III - IV	MAX	60	mA
		II		120	
(D <sub>l</sub> /d <sub>t</sub> )(2)	V <sub>D</sub> =67%V <sub>DRM</sub> Gate open T <sub>j</sub> =125°C		MIN	400	V/us
(D <sub>l</sub> /d <sub>t</sub> )c(2)	(D <sub>v</sub> /d <sub>t</sub> )c=7 A/ms T <sub>j</sub> =125°C		MIN	10	V/us

### Static Characteristics

Symbol	Test conditions	Value		Unit	
V <sub>TM</sub> (2)	I <sub>T</sub> M=11A t <sub>p</sub> =380us	T <sub>j</sub> =25°C	MAX	1.55	V
V <sub>to</sub> (2)	Threshold voltage	T <sub>j</sub> =125°C	MAX	0.85	V
R <sub>d</sub> (2)	Dynamic resistance	T <sub>j</sub> =125°C	MAX	35	mΩ
I <sub>DRM</sub> I <sub>RRM</sub>	V <sub>DRM</sub> =V <sub>RRM</sub>	T <sub>j</sub> =25°C	MAX	5	uA
		T <sub>j</sub> =125°C		2	mA
V <sub>DRM</sub> /V <sub>RRM</sub>	Voltage	T <sub>j</sub> =25°C	MIN	600 and 800	V

**Note 1:** minimum IGT is guaranteed at 5% of IGT max

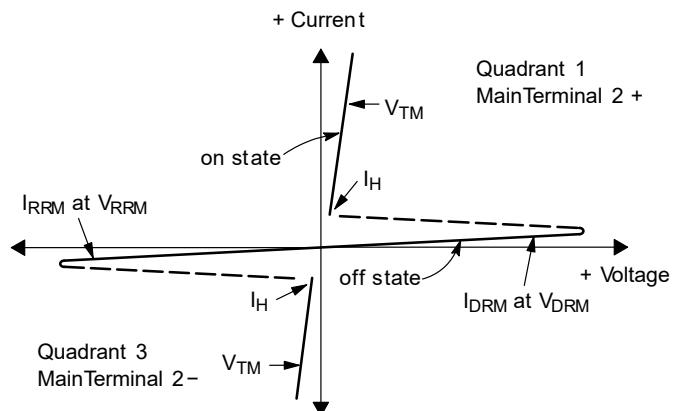
**Note 2:** for both polarities of A<sub>2</sub> referenced to A<sub>1</sub>

### Thermal Resistances

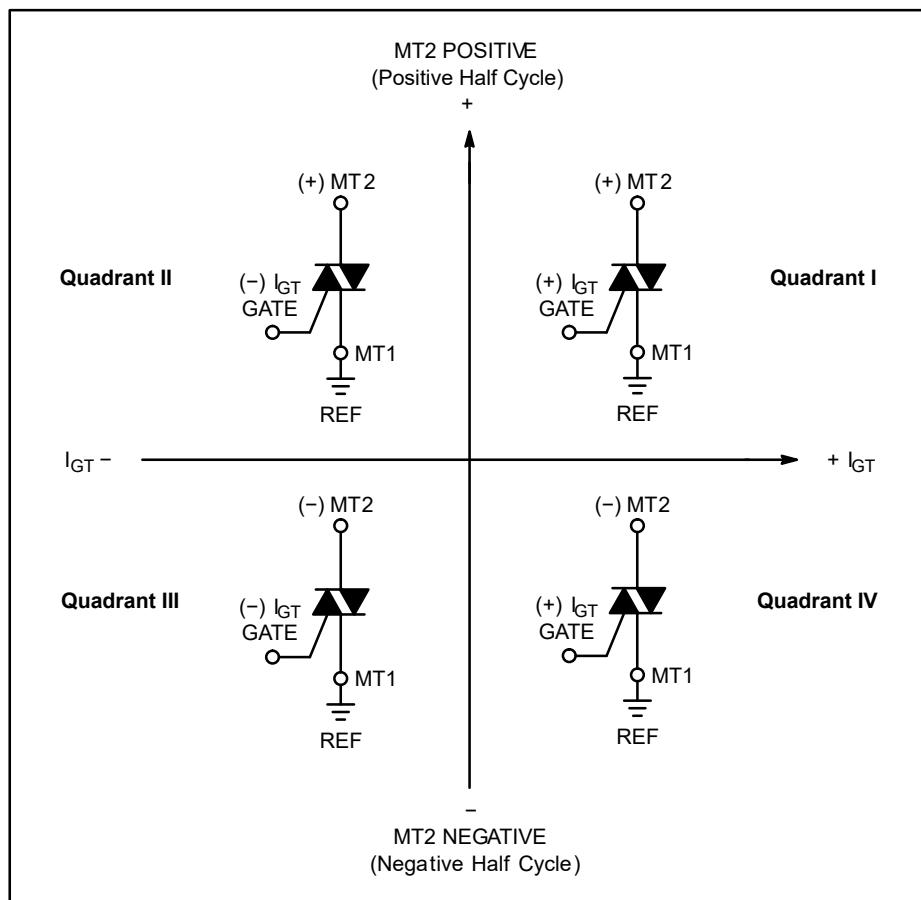
Symbol	Parameter	Value	Unit
R <sub>th(j-c)</sub>	Junction to case(AC)	TO-263	1.2 °C/W
R <sub>th(j-a)</sub>	Junction to ambient	TO-263	60 °C/W

## Voltage Current Characteristic of Triacs (Bidirectional Device)

Symbol	Parameter
$V_{DRM}$	Peak Repetitive Forward Off State Voltage
$I_{DRM}$	Peak Forward Blocking Current
$V_{RRM}$	Peak Repetitive Reverse Off State Voltage
$I_{RRM}$	Peak Reverse Blocking Current
$V_{TM}$	Maximum On State Voltage
$I_H$	Holding Current

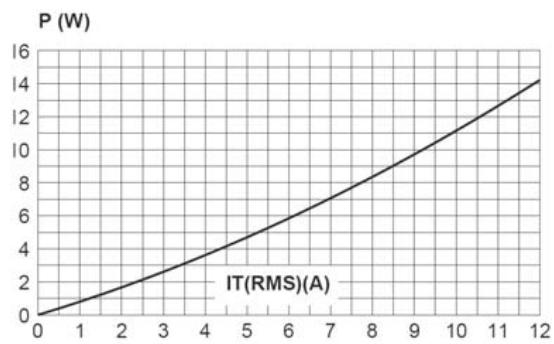


Quadrant Definitions for a Triac

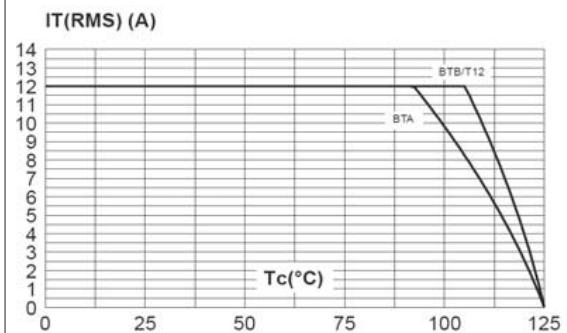


All polarities are referenced to MT1.  
With in-phase signals (using standard AC lines) quadrants I and III are used .

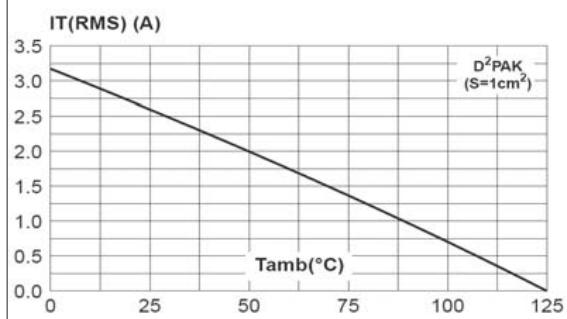
**Fig. 1:** Maximum power dissipation versus RMS on-state current (full cycle).



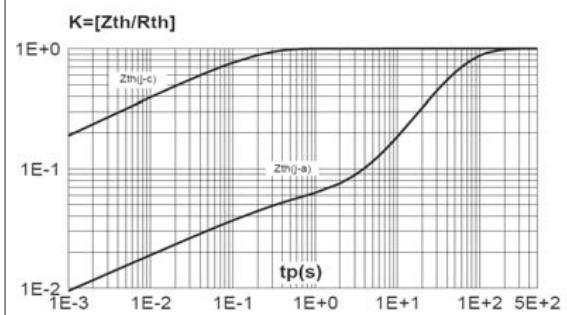
**Fig. 2-1:** RMS on-state current versus case temperature (full cycle).



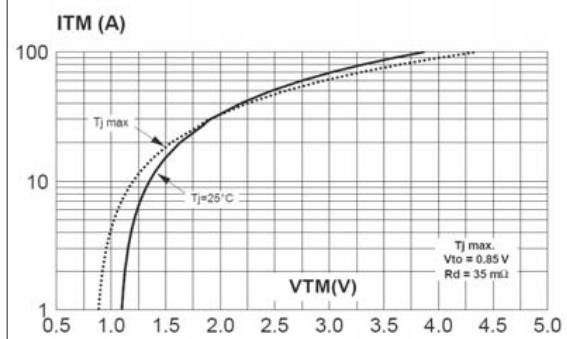
**Fig. 2-2:** RMS on-state current versus ambient temperature (printed circuit board FR4, copper thickness: 35µm), full cycle.



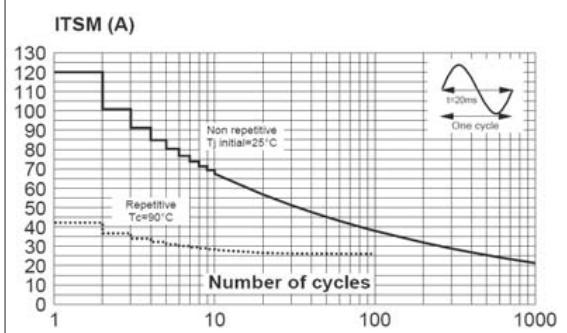
**Fig. 3:** Relative variation of thermal impedance versus pulse duration.



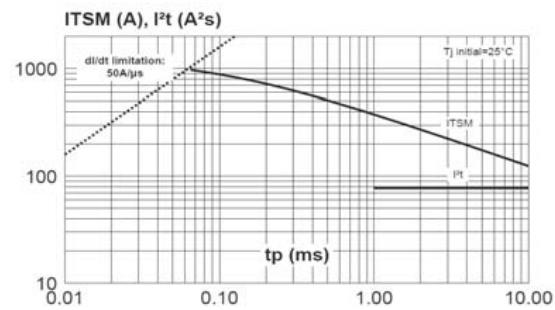
**Fig. 4:** On-state characteristics (maximum values).



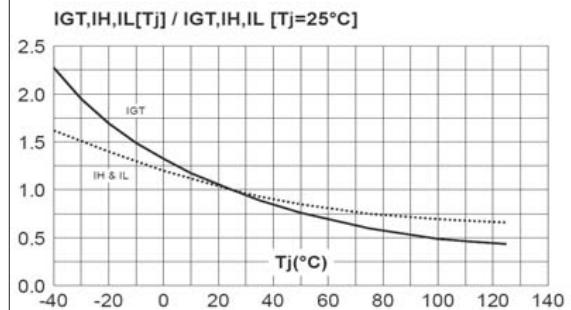
**Fig. 5:** Surge peak on-state current versus number of cycles.



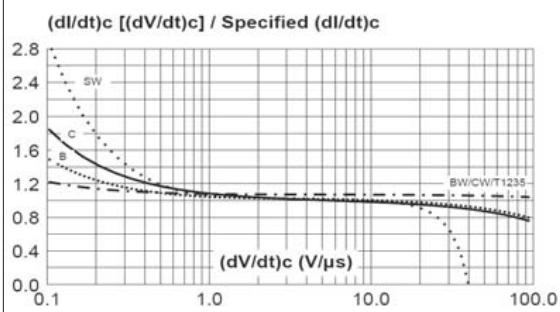
**Fig. 6:** Non-repetitive surge peak on-state current for a sinusoidal pulse with width  $t_p < 10\text{ms}$ , and corresponding value of  $I^2t$ .



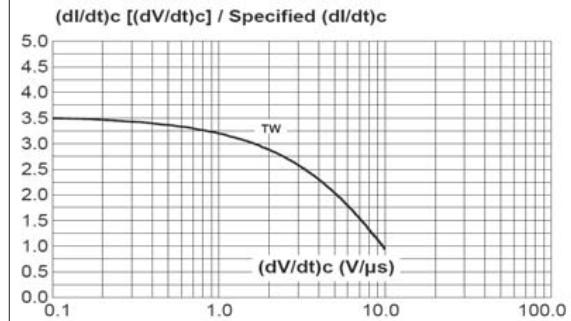
**Fig. 7:** Relative variation of gate trigger current, holding current and latching current versus junction temperature (typical values).



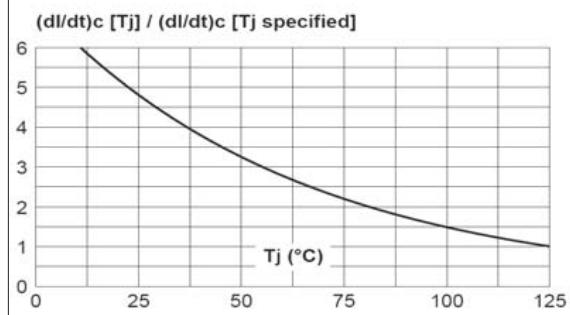
**Fig. 8-1:** Relative variation of critical rate of decrease of main current versus  $(dV/dt)c$  (typical values) (BW/CW/T1235).



**Fig. 8-2:** Relative variation of critical rate of decrease of main current versus  $(dV/dt)c$  (typical values) (TW).



**Fig. 9:** Relative variation of critical rate of decrease of main current versus junction temperature.



**Fig. 10:** D<sup>2</sup>PAK Thermal resistance junction to ambient versus copper surface under tab (printed circuit board FR4, copper thickness: 35  $\mu\text{m}$ ).

